

N/MEMs: Small Components Enable Powerful Microsystems

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Defense Advanced Research Projects Agency (DARPA)**

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**8 April 2010
*SPIE Defense, Security, and Sensing***



N/MEMS Are Everywhere

Microstructures

Hewlett Packard

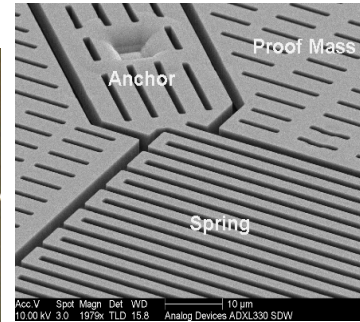


Microsensors

Analog Devices



Air Bag Deployment Accelerometer



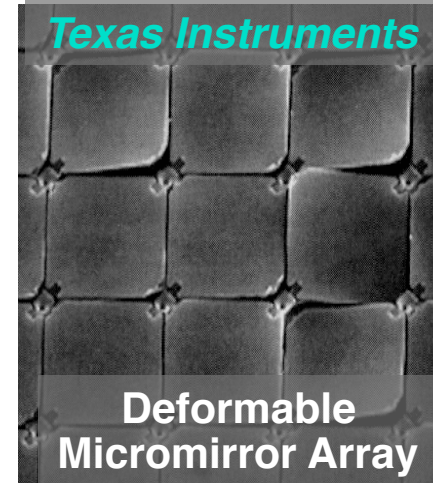
Wii

Thermal Ink Jet

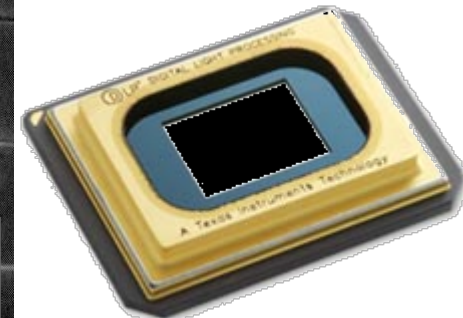


Microactuators

Texas Instruments



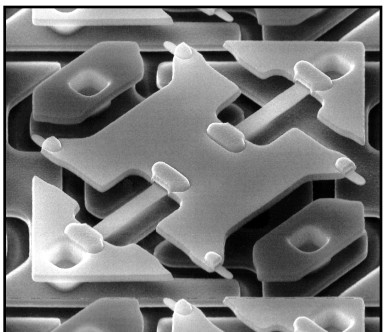
Deformable Micromirror Array





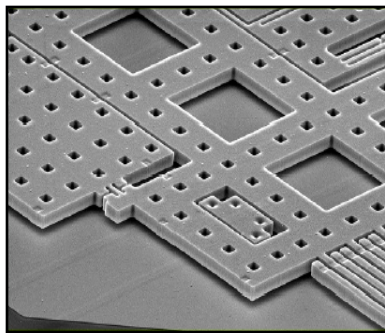
Successful Component Demonstrations

DARPA Microsystems Technology Office (MTO) MEMS program has focused on the development of enabling component capabilities for new DoD systems.



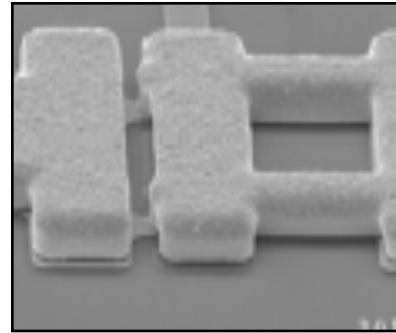
Texas Instruments

Displays



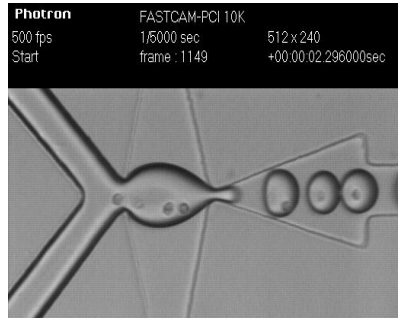
Analog Devices

Accelerometers

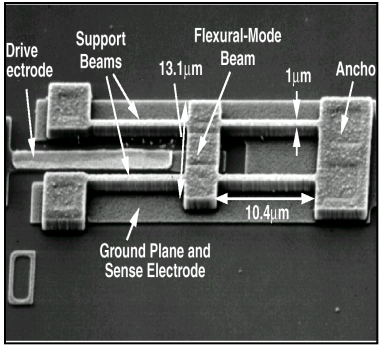


Radant

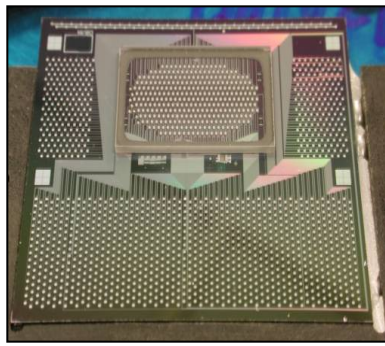
RF Switches



Bio Fluidic Processors

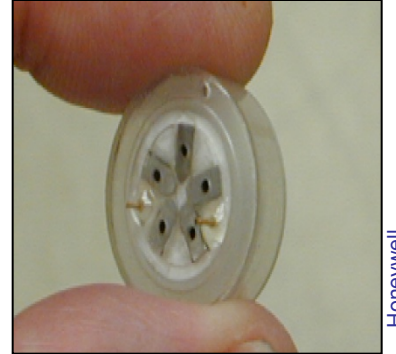


RF Resonators



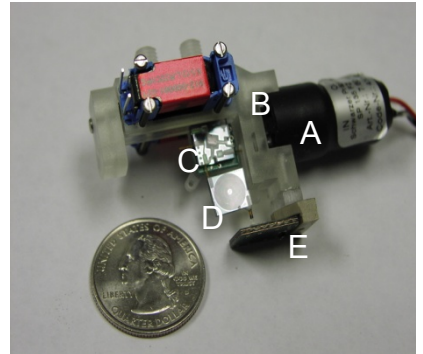
Callnet

Optical switches



Honeywell

Fuel Cells



Micro Gas Analyzers

Performance

Capabilities

Size

Speed



MEMS Programs

- DARPA played the leading role in the U.S. in the development of MEMS
- Component-level demonstrations and advanced capabilities important to DoD
 - Accelerometers/Gyroscopes
 - RF Switches/Resonators
 - Fluid processing
 - Digital displays
 - Chemical sensors
 - Fuel Cells
- Current DARPA MTO programs focus on miniaturization to drive systems performance
 - Fundamental Research
 - Specific DoD Applications

DARPA MEMS Programs

- **MEMS (1993-2000)**
 - Micro Fluidic Systems
 - BioFlips
 - MEMS Exchange
 - Chip-Scale Atomic Clock
 - Harsh Environment Robust Micromechanical Technology
 - 3-D MERFS
- **Micro Gas Analyzer**
- RF MEMS Improvement
- Micro Isotope Power Sources
- Micro Electric Propulsion
- Navigation Grade Micro Gyroscopes
- Micro Cryogenic Coolers
- **N/MEMS S&T Fundamentals**
- Analog Signal Processors
- Hybrid Insect MEMS
- Tip-Based Nanofabrication
- Thermal Ground Plane
- **Nano Electro Mechanical Switches**
- Micro Inertial Navigation Technology
- **SERS S&T Fundamentals**
- **Chip Scale Spectrum Analyzers**
- Chip Scale Vacuum Micropumps
- Active Cooling Modules
- Dynamics-Enabled Frequency Sources

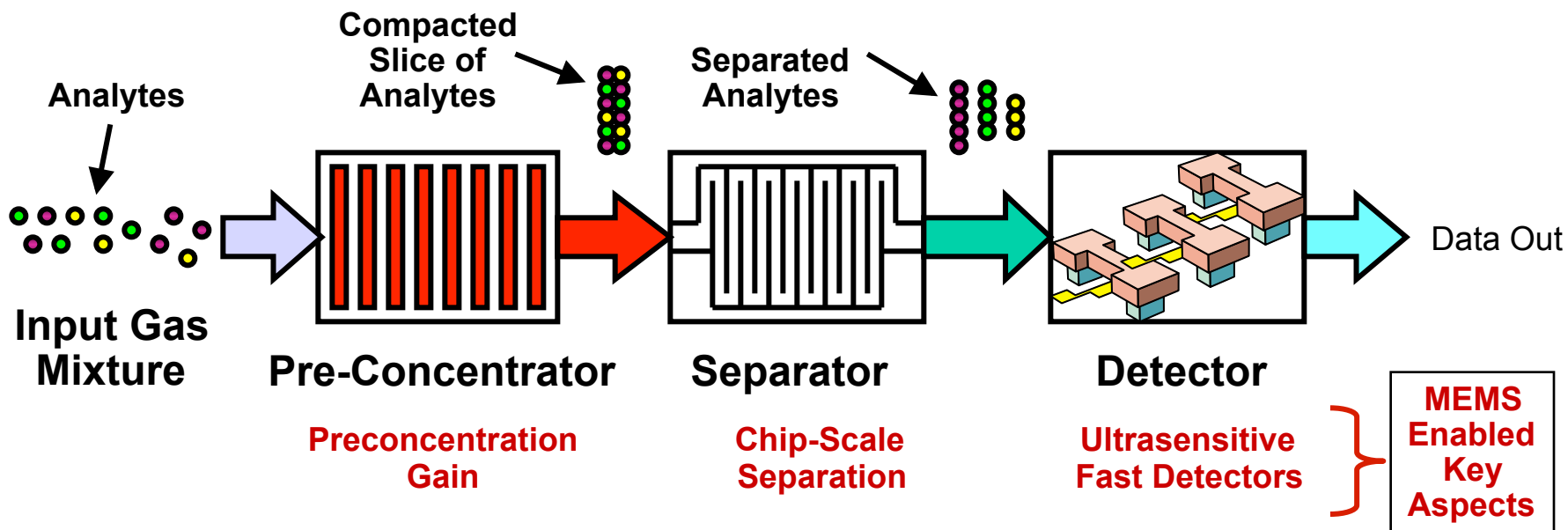


Key DARPA MTO Themes

- 1. N/MEMS Enables Significant New Levels of Performance**
2. Scaling – “Smaller is Better”
3. N/MEMS Integration
4. Enabling Completely New Opportunities
5. Basic Research Infrastructure is Important



Chip Scale Micro Gas Analyzers (MGA)



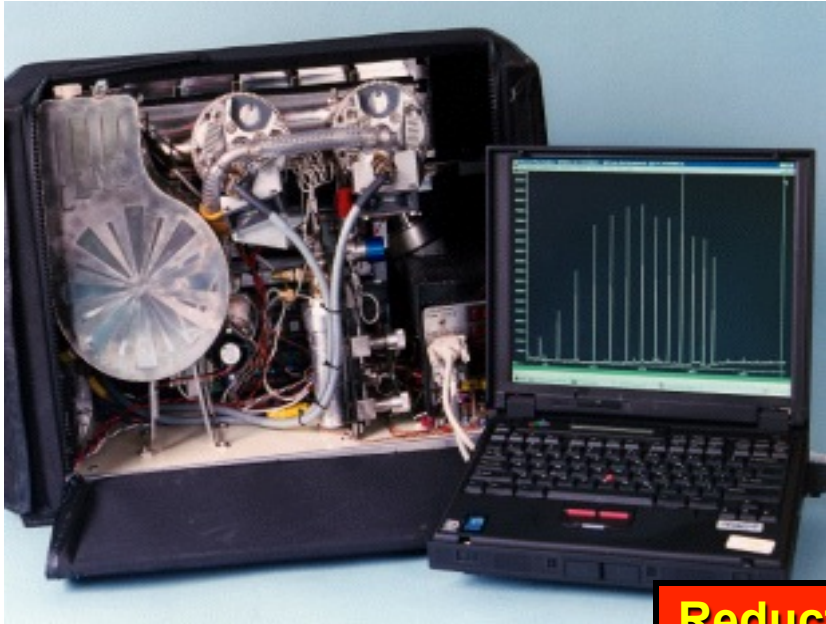
- **Objective:**
Enable chemical detection via tiny, ultra-low power, fast, high sensitivity, chip-scale gas analyzers with low incidence of false positives.
- **Approach:**
Use MEMS and nanotechnologies to implement analyte preconcentration, separation, (e.g., gas chromatography), and detection at the micro-scale to enhance gas selectivity.



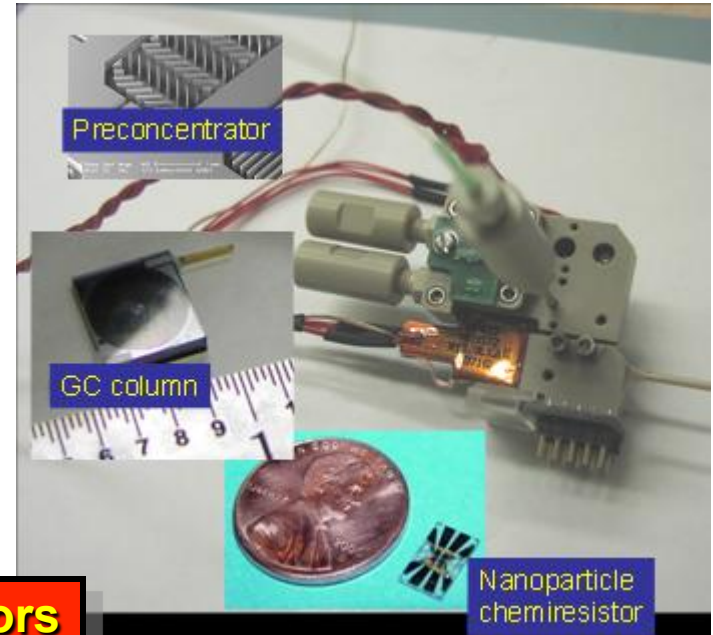
Revolutionary Devices: DARPA MGA



Portable Gas Chromatograph



Chip-Scale Gas Chromatograph



Reduction Factors

Size	40,500 cm ³	20,000X	Size	2 cm ³
Sensitivity	1 ppb	1,000X	Sensitivity	1 ppt
Analysis Time	15 min.	225X	Analysis Time	4 sec
Energy Per Analysis	10,000 J	1,000X	Energy Per Analysis	10 J



MGA Performance Metrics Achieved



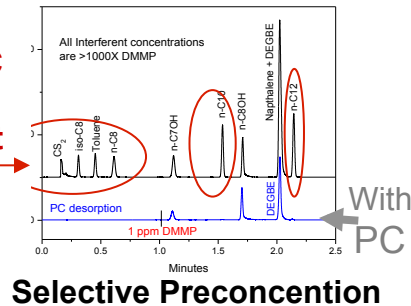
Preconcentration:

- Microstructures with selective coating
- High efficiency, high specificity chemical collection and release (PC Gain >1000)



Micro Preconcentrator

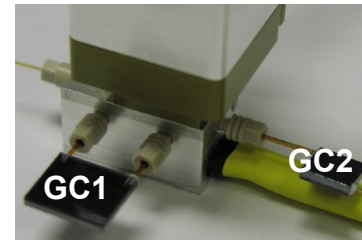
Selective PC
does not
adsorb most
common
interferents



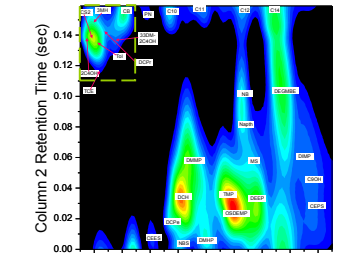
PI: Simonson (Sandia)

Separation:

- 2 column gas chromatography, GCxGC
- Extremely rapid (< 4 sec) separation of large numbers of compounds for fast analysis and low FAR



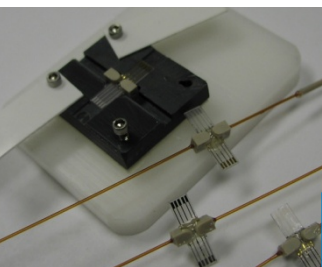
GCxGC Test Module



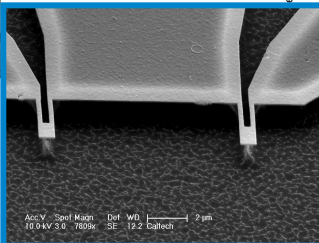
PI: Simonson (Sandia)

Detector: Nanocantilever Array

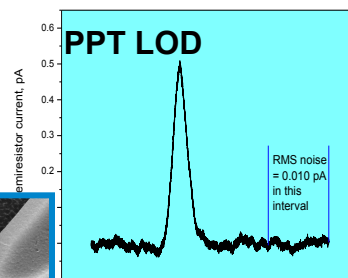
- High sensitivity sensor arrays
- Specific detection for low FAR



Chemiresistor Array



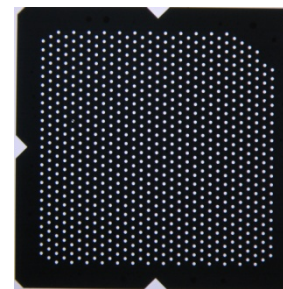
Nanocantilever Array



PI: Roukes (Caltech)

Detector: Mass Spec

- Microscale ion trap mass spectrometer.
- Operation at 1000X higher pressure than conventional MS demonstrated
- Broad chemical detection capability



Ion Trap Array



MS Test Module

PI: Ramsey (UNC/ORNL)



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Nanoscale Resonant Detectors

Objective

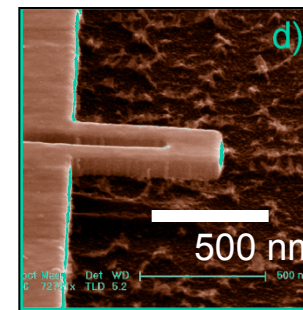
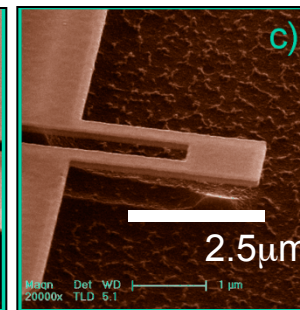
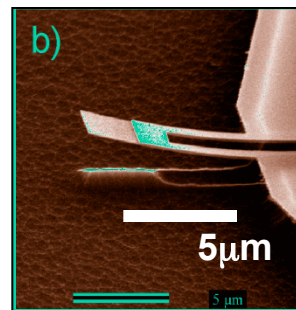
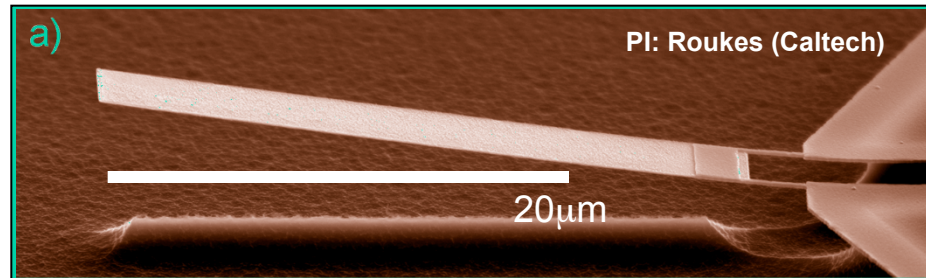
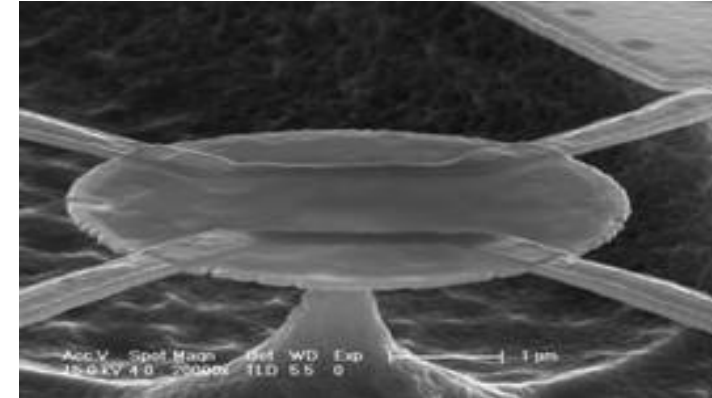
Effort in focuses on developing ultrasensitive, low power, miniaturized nanomechanical mass detectors for MGA applications.

Technical Approach

Measurement of resonant frequency shift in response to accretion of gas molecules on the surface of piezoresistive nanomechanical resonators.

Challenges

Device nanofabrication, design and realization of ultrasensitive transducer, surface functionalization at the nanoscale, and realization of ambient pressure operation.



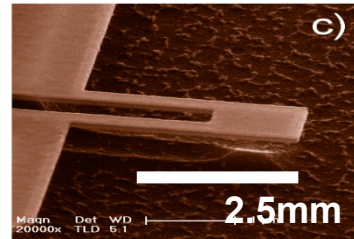


Nano “value added”: Frequency, Compliance Scaling

With uniform scaling of all dimensions, $w = a\ell, t = b\ell, L = c\ell$

- **Scaling of frequency**

$$f_0 \approx \alpha \sqrt{E / \rho} \frac{t}{L} \propto \frac{1}{\ell}$$



↑ with decreasing ℓ

- **Scaling of compliance (force responsivity)**

$$k_{eff} \approx \beta E w \left(\frac{t}{L} \right)^3 \propto \ell$$

↓ with decreasing ℓ

- **Scaling of thermomechanical noise**

$$S_F^{\frac{1}{2}} = \left(\frac{4k_B T k_{eff}}{\omega Q} \right)^{\frac{1}{2}} \propto \ell$$

↓ with decreasing ℓ



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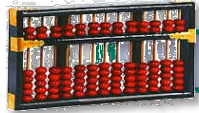


Nano Electro Mechanical Switches (NEMS) Overview

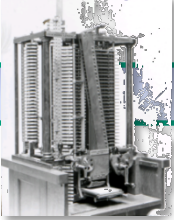


PM: T. Akinwande

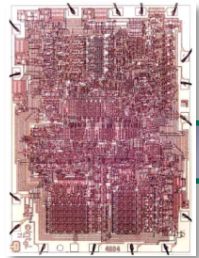
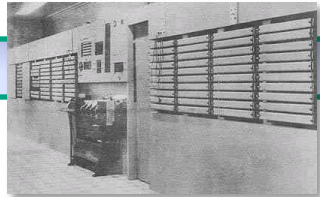
Abacus



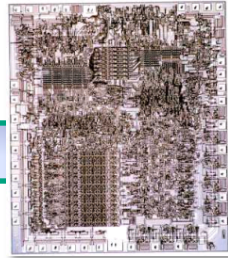
Babbage



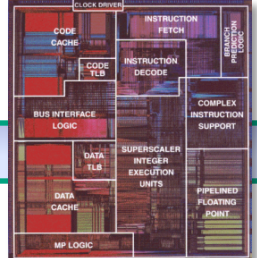
Relay computer
(circa 1950)



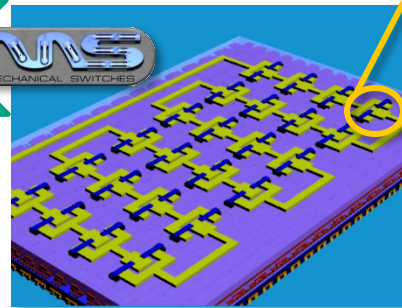
4004 (1971)



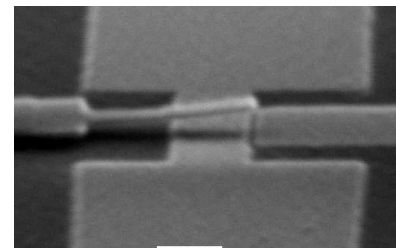
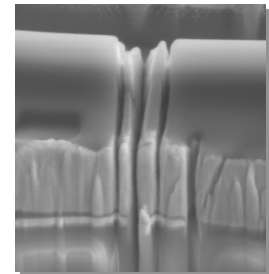
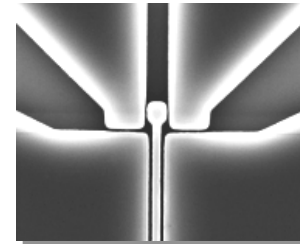
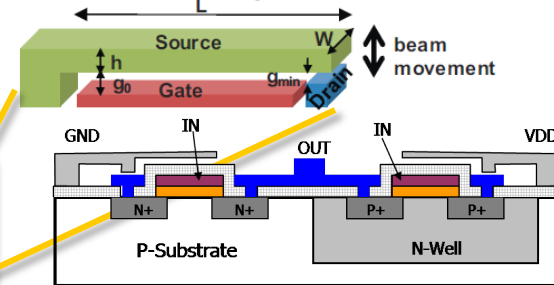
8086 (1978)



Pentium (2006)



Hybrid NEMS/CMOS Device Integration



Objectives

- Eliminate leakage power in electronics to enable longer battery life and lower power required for computing
- Enable high temperature operation (Carnot efficient hot computing)
- Push scaling limits with all-mechanical/hybridization computing

Technical Challenges/Approach

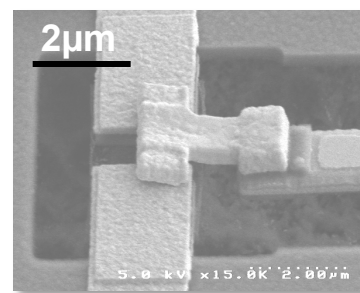
- 1 Volt, 1 nanosecond operation : sub-50nm dimensions
- Reliable nanoscale contacts & stiction : ALD materials, AFM resistance measuring techniques, etc.
- Gate dielectric charging : High K, body biasing, modulated timing signals

Significant NEMS Achievements

PM: T. Akinwande

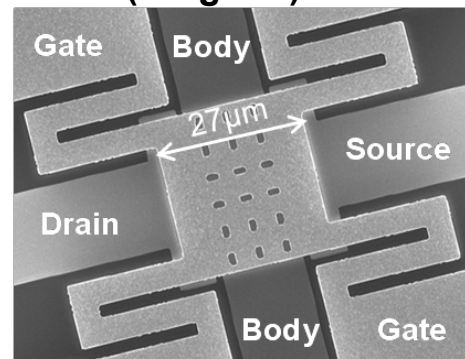
Phase I Accomplishments:

- Demonstrated pathways to CMOS-NEMS hybrid implementation of FPGAs [C. Chen et al., FPGA'10]
- Demonstration of high-temperature digital C-NEMS
- Demonstration of first-ever nanoscale mechanical relays and logic elements with manufacturability and repeatability [IEDM 2009]
- Demonstration of first body-biased mechanical logic elements and Complementary NEMS (C-NEMS) switches
- Demonstrated analog amplification using NEMS "resoswitch"
- Demonstration of CNEMS logic with >10X improvement in both static and dynamic power consumption compared to the 65nm node CMOS ICs
- Demonstration of CNEMS Digital, Mixed Signal & Analog Circuits [ISSCC 2010]
- Demonstration of new processing techniques for all-CNT switches, obviating the need for aligned CNT films, and highly reproducible & uniform layer by layer process

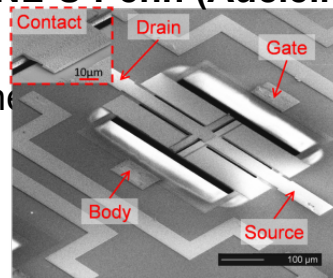


ARL (Polcawich)

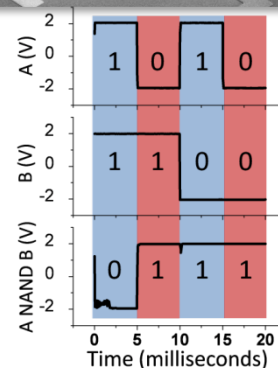
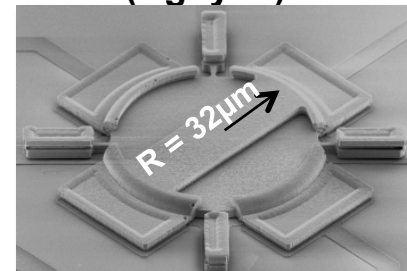
UCB (King-Liu)



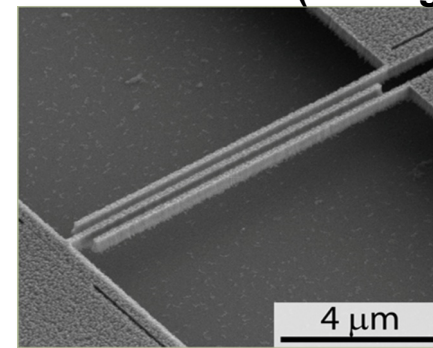
ANL-U Penn (Auciello)



UCB (Nguyen)



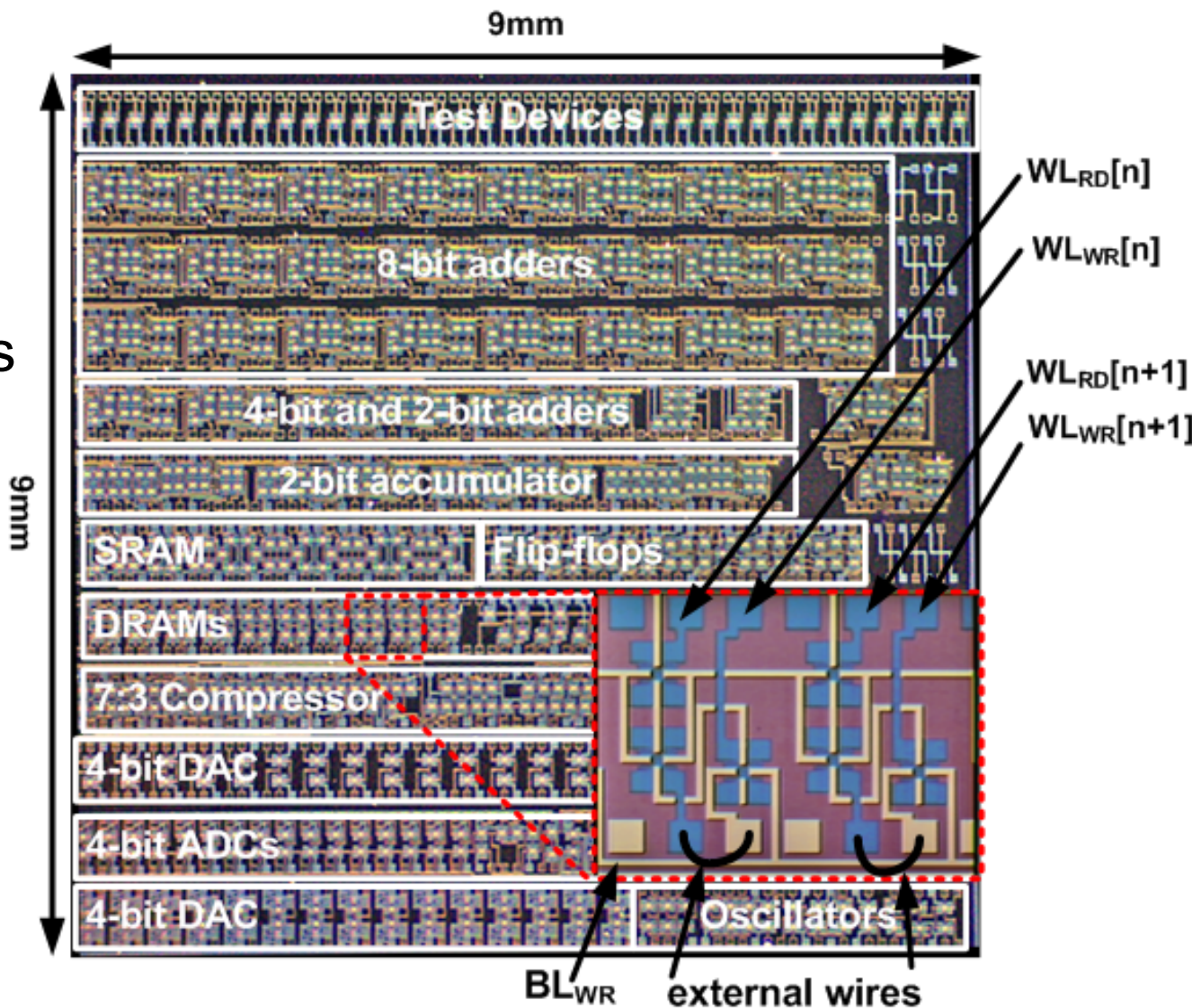
CWRU SiC NEMS (Mehregany)



C-NEMS Circuits Test Chip UC Berkeley (King-Liu)

PM: T. Akinwande

- DAC
- ADC
- Adders
- Flip-flops/Latches
- Memories
- Oscillators
- Inverter VTC suggests composability...



F. Chen et al., 2010 ISSCC

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Micro Cryogenic Coolers (MCC)



Problem

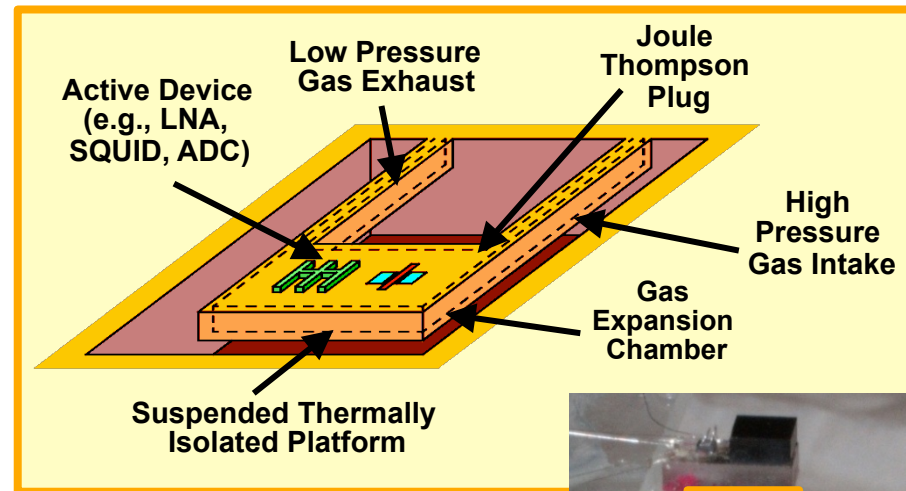
Need to reduce both size (< 4 cc) and power consumption (< 100 mW) of cryogenic coolers by significantly increasing thermal isolation and refrigeration capability for low-power sensors

Goal: Scalable and reliable Cryo Cooling

- 3 to 50 mWatt heat lifts
- Ambient temperatures from 300 to 380 K
- Sensor platform targeting 77 to 200 K
 ΔT currently 150 K, goal is > 200 K
- Cold stage includes planar heat exchanger
- MEMS-based compressor with size and power minimized for 4:1 pressure ratio

DoD Impact

- Increase threat detection range by $> 2x$ for helicopter IR counter measure systems
- Huge reduction in SWaP for Fourier Transform Infrared Spectroscopy (FTIR) biosensors

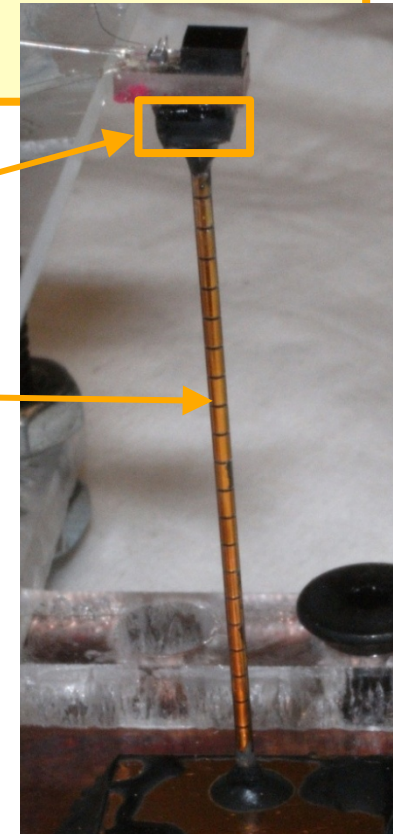
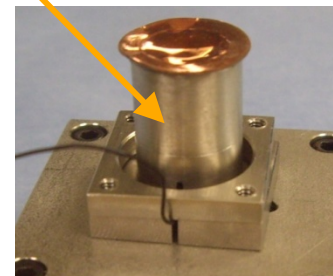


Cooler Head: < 0.1 cc

A small thermal imaging array is mounted on top of the cooler

Compressor piston inside housing under base

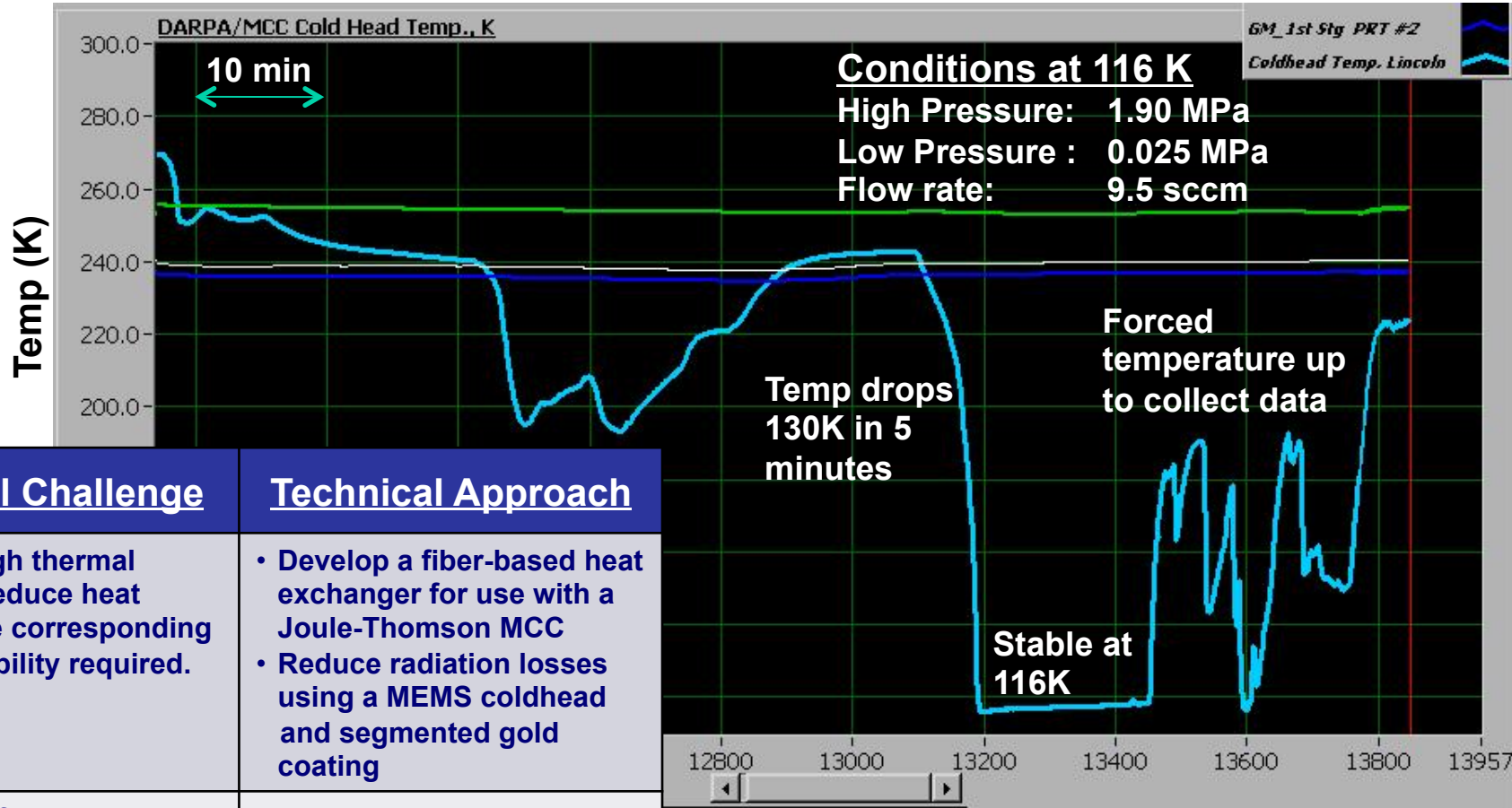
Thermal isolation several cm long





University of Colorado (YC Lee)

Heat Lift >3mW, $\Delta T >150$ K



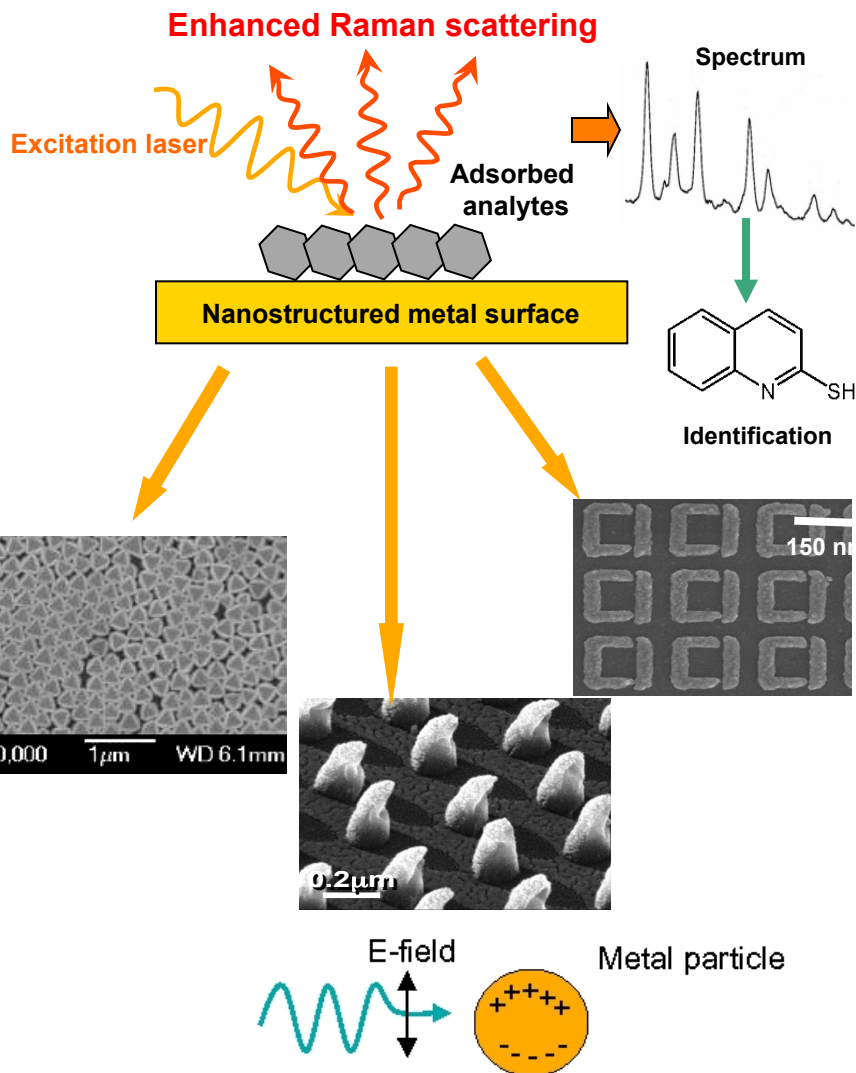
Technical Challenge	Technical Approach
Achieving high thermal isolation to reduce heat loads and the corresponding cooling capability required.	<ul style="list-style-type: none">• Develop a fiber-based heat exchanger for use with a Joule-Thomson MCC• Reduce radiation losses using a MEMS coldhead and segmented gold coating
Increasing refrigeration capability to reduce flow rate and the corresponding compressor size and power.	<ul style="list-style-type: none">• Design an optimum gas mixture for specific temperature and pressure ranges.
Fabrication of a small and low-power compressor.	<ul style="list-style-type: none">• Use a gas mixture designed for low P ratio.• Employ piezoelectric-based actuation.



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Surface-Enhanced Raman Spectroscopy Science & Technology Fundamentals (SERS S&T)



Goal:

- Enable 0.1 to 10 km stand-off detection of CWAs, BWAs, TICs, and explosives
- Decrease false alarm rates by 3-4 orders of magnitude
- To fabricate reproducible, large scale (6") SERS materials with Enhancement Factors $>10^{12}$
- Enable handheld microsystems capable of multipathogen screening
- Understand the origins and mechanisms of SERS

Technical Challenges:

- Obtain theoretical and experimental data that increases Enhancement Factors
- Synthesize resonance enhanced reporters, nanoparticle attachments and encapsulants
- Determine excitation wavelength dependence

Key Accomplishments:

- Through nano-antenna design based on theoretical modeling, reproducible EFs of 10^9 have been achieved

Impact:

- Ultra-bright nanoparticles and nanostructures with SERS Enhancement Factors $>10^{12}$ will lead to a new generation of highly sensitive, low-FAR nanosensors

Novel SERS Substrates Will Revolutionize Chem/Bio Detection for DoD



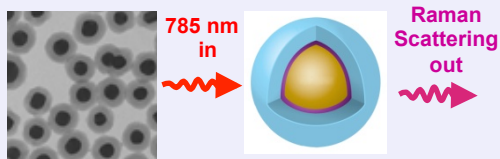
Six Unique SERS S&T Approaches



PI: R. Van Duyne

Northwestern University

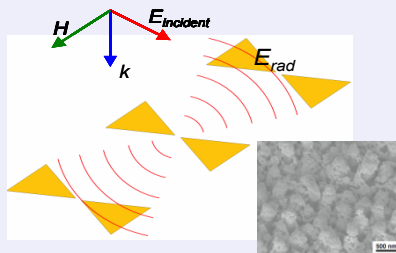
Controlled synthesis of unit cell nanoantenna structures; EM theory; precision molecule placement



PI: K. Crozier

Harvard University

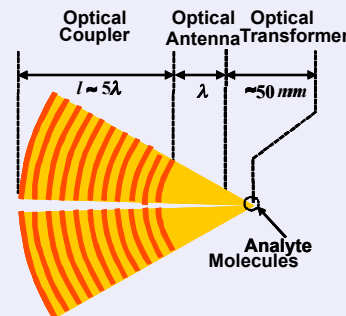
Radio engineering of periodic optical antennas, laser nanostructuring of surfaces



PI: Ming Wu

UC Berkeley

Gradient optical coupling; integrated optical antennas

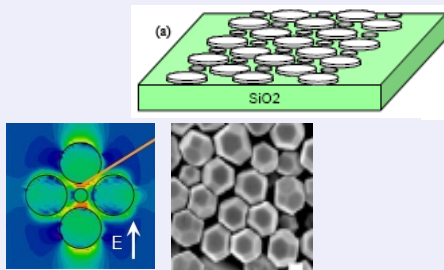


SERS S&T Fundamentals Enhancement Factor Theory / Modeling / Fabrication / Testing

PI: Zhiyong Li

Hewlett Packard

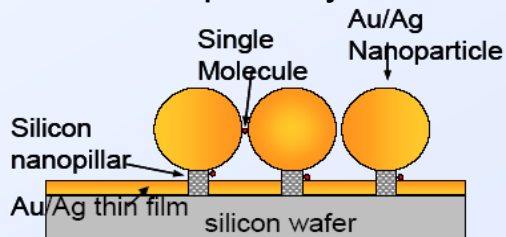
Plasmonic nanolens arrays with faceted SERS crystals



PI: T. Bond

Lawrence Livermore (LLNL)

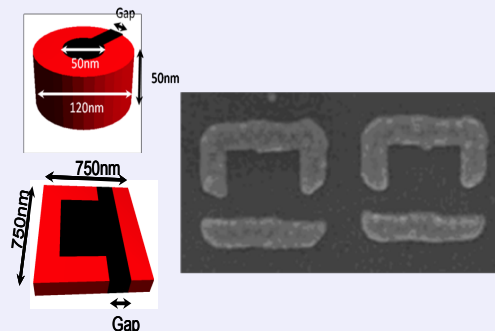
3D vertical nanopillar arrays



PI: S. Chou

Princeton University

Nanogap arrays by nanoimprinting





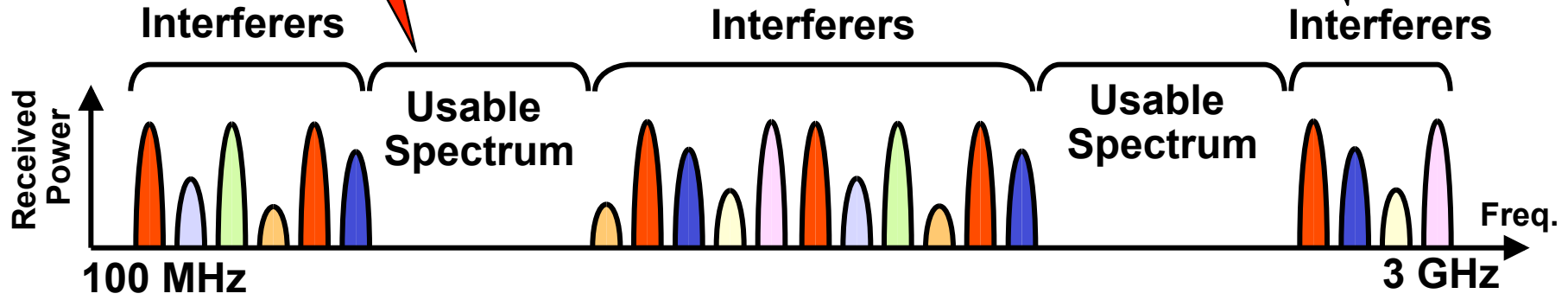
Software-Defined Cognitive Radios

Cognitive: identifies unused spectrum, then operates there

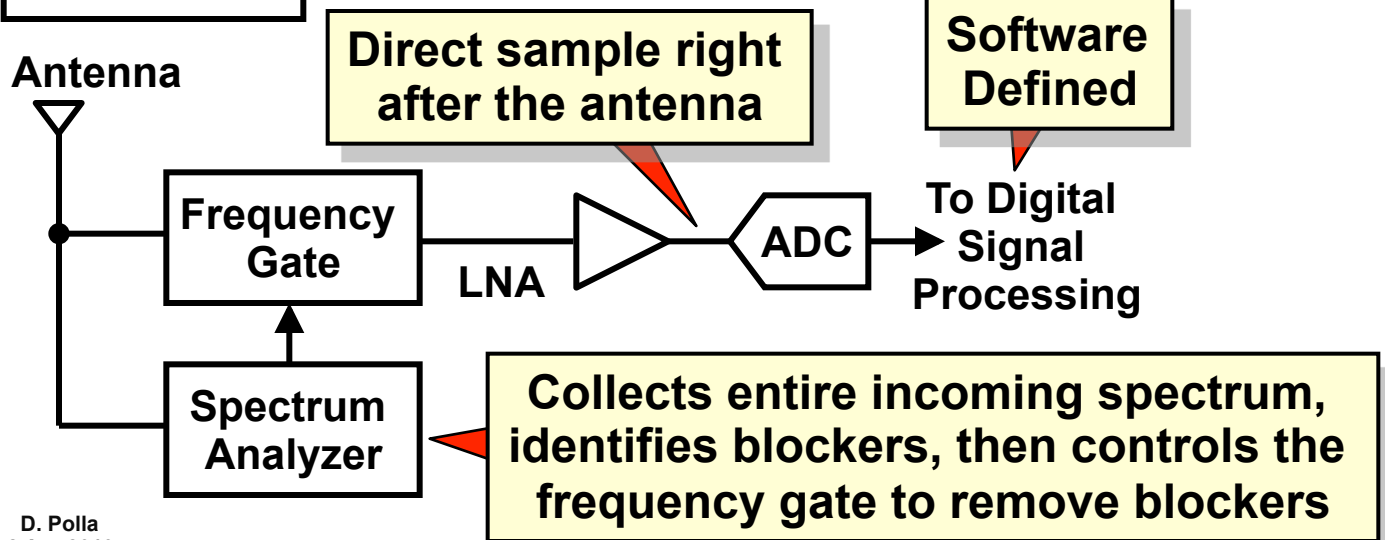
Need: ultra-fast spectrum analyzer

Software-Defined: digitizes right after the antenna

must remove interferers to do this



Solution:



Why can't we do this today?

Today's spectrum analyzers too large, too slow, and too power hungry

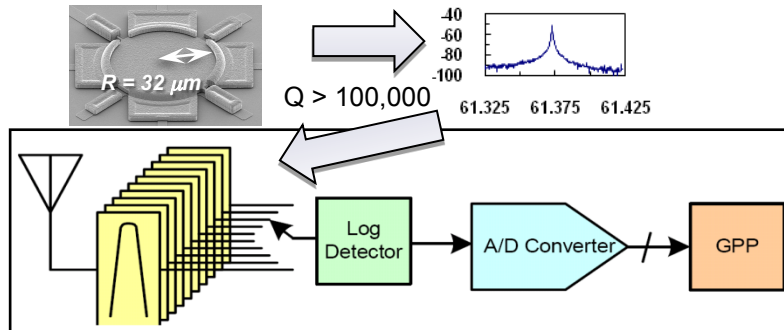


Chip-Scale Spectrum Analyzers (CSSA)

Program Objective: To develop a 100-channel spectrum analyzer capable of 3 GHz operation with $Q > 100,000$, an input impedance $< 50 \Omega$, resolution bandwidth < 30 kHz, and low insertion loss.

Motivation: compact, jam-resistant, low-power, intelligent radio.

One Hundred Fixed Frequency Filters

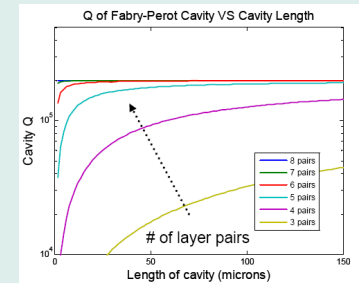
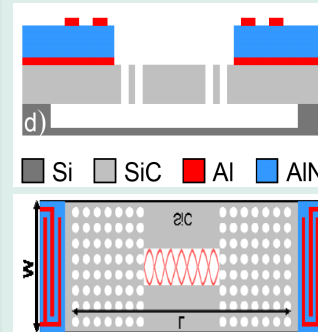


Technical Approach / Key Technical Challenges:

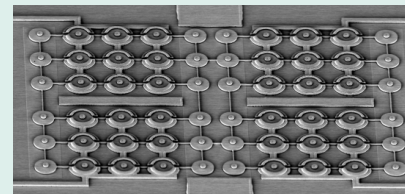
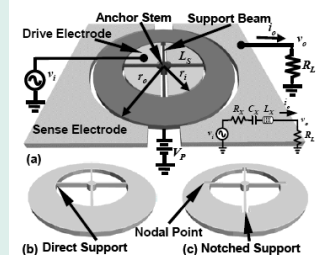
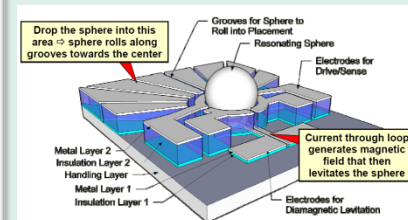
- Development of new anchoring technologies
- Adaptation of new materials (SiC, Al_2O_3 , CNTs, AlN)
- Key challenge: Developing optimal design/material combinations that minimize energy losses required for achieving extremely high Q ($> 100,000$)

Status: Recently Started

Over-moded resonators and phononic crystal interfaces



Mechanically coupled Q-boosting resonators, low-loss forms, anchors, and materials (SiC, Al_2O_3 , CNTs, AlN)



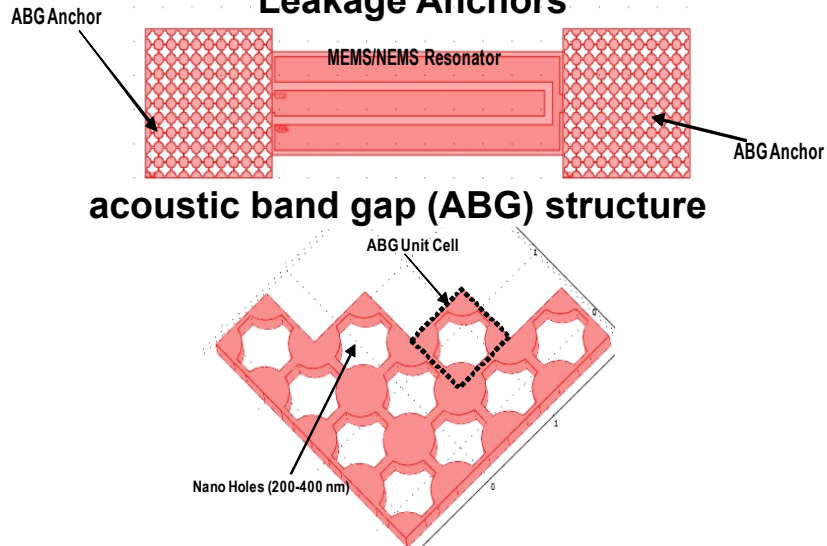
Array of coupled MEMS polysilicon resonators



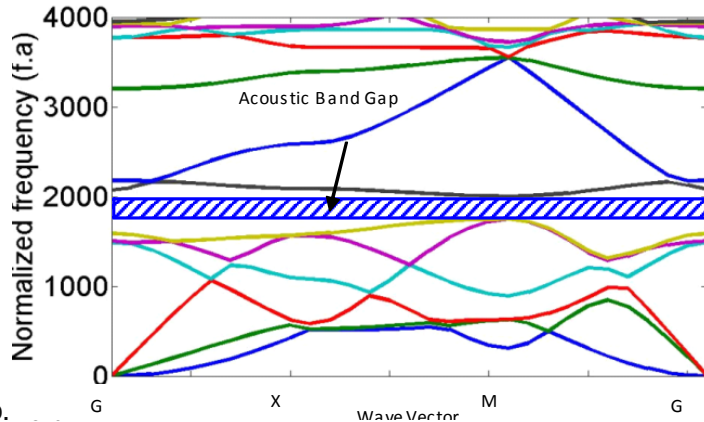
CSSA Initial Results

Northrop Grumman (D Adam)

Acoustic Band-gap Structures for Low Leakage Anchors

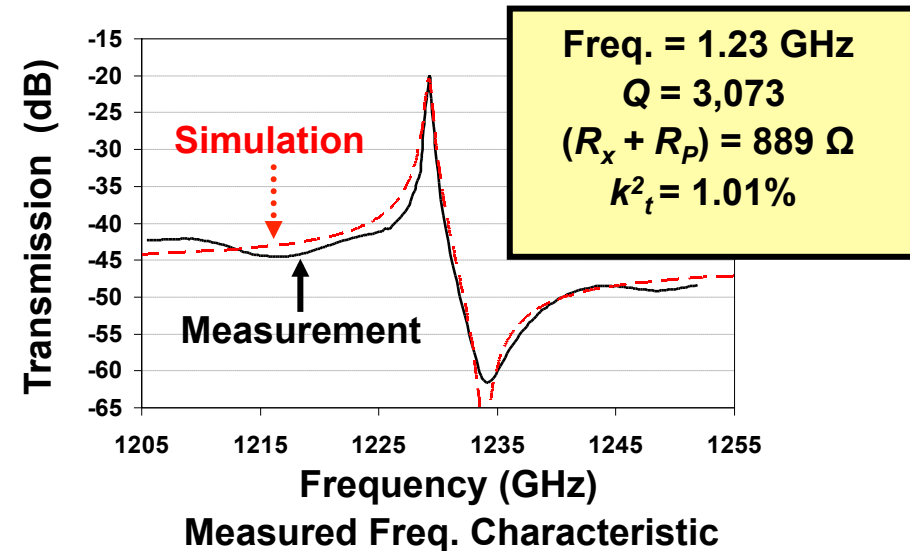
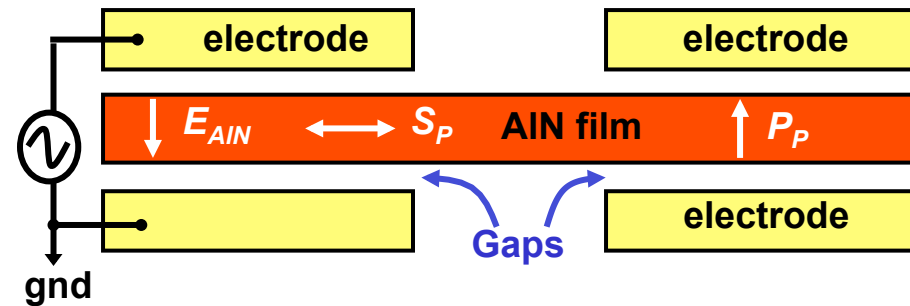


COMSOL FEM simulation shows 14% band-gap



UC Berkeley (C Nguyen)

AlN Ring Resonator Equipped w/ Capacitive-Piezo Transducers





Key DARPA MTO Themes

1. N/MEMS Enables Significant New Levels of Performance
2. Scaling – “Smaller is Better”
3. N/MEMS Integration
4. Enabling Completely New Opportunities
5. **Basic Research Infrastructure is Important**



N/MEMS S&T Fundamentals



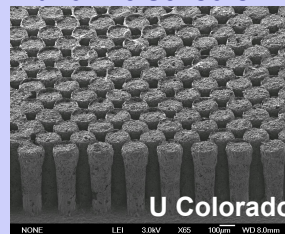
Program Objective:

To develop an advanced fundamental understanding in key technical areas important to the continuing development of N/MEMS technology and its transition into defense systems.

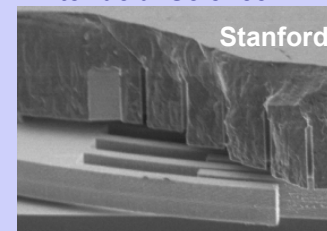
Technical Approach / Key Technical Challenges:
Basic Research: Understanding key issues involving nano/micro interfaces, scaling laws, failure mechanisms, microfluidics, photonics, N/MEMS materials and processes, et al.

Building on Strong Record of Accomplishments:
Publications and patents, transitions to new DARPA programs, industry cost-sharing, educating next-generation N/MEMS researchers

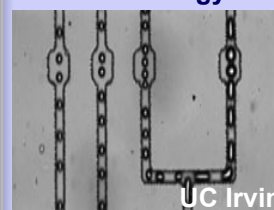
Nanowire Sensors



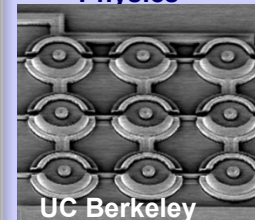
Interfacial Science



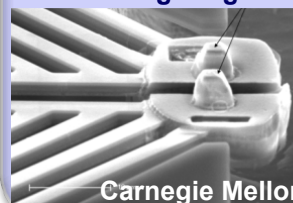
Microfluidics and Biotechnology



Scaling-Induced Physics



Self-Configuring ICs



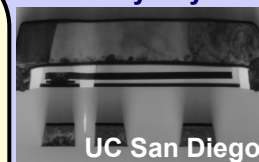
Focus Areas

- Reliability
- Molecular Devices
- Reconfigurability
- Interfaces
- Interconnects
- Scaling Limits
- Nanostructures
- Modeling
- Power Sources
- Materials
- Self-Assembly
- Photonics

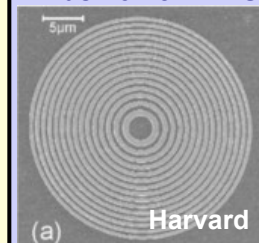
Nano Probes



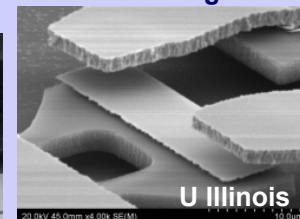
Reliability Physics



Plasmonic MEMS



Multi-Physics Modeling





N/MEMS S&T Fundamentals



Strong Record of Program Accomplishment in Phase I

- More than **350** publications derived from supported research in technical journals and conference proceedings
- Approximately **200** additional conference presentations
- More than **30** patents – pending or issued
- Research is contributing to the education of **~200** graduate students; work also involves participation by **48** post-docs
- Program research oversight and guidance provided by **90** faculty
- Cost-sharing support in Phase I provided by **68** industry program partners; industry funding met DARPA expectations

Program has a profound effect establishing a broad N/MEMS community and accelerating technical progress important to transitioning emerging capabilities.



N/MEMS S&T Fundamentals Performers



N/MEMS S&T 2006-2009

- Caltech
- Carnegie Mellon University
- Cornell University
- Harvard University
- MIT
- Stanford University
- UC Berkeley
- UC Irvine
- UC San Diego
- University of Colorado
- University of Illinois



N/MEMS S&T Fundamentals Massachusetts Institute of Technology



Focus Center on Non-Lithographic Techniques for N/MEMS

PI: M Schmidt

Mission: To develop revolutionary methods for fabricating N/MEMS without the need for planar lithography

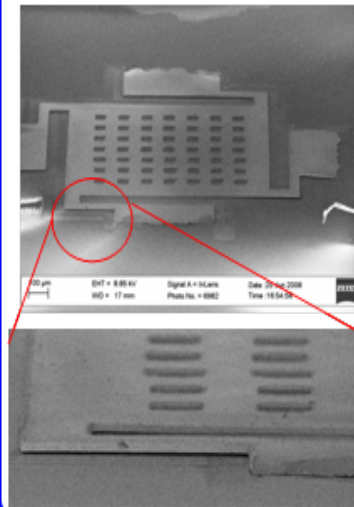
- N/MEMS technology currently constrained by the inability to prototype and manufacture products rapidly and cost-effectively in small/medium volume: A new paradigm is needed to break this log-jam
- Leverage high-resolution printing processes to deposit exotic materials at desired locations

Key Accomplishments:

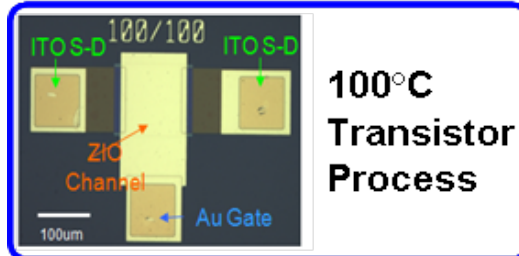
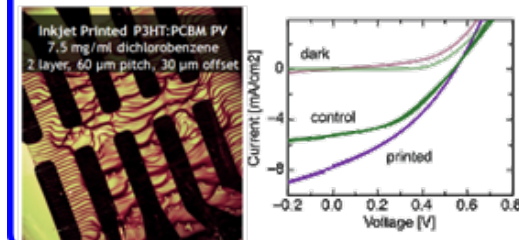
Developed a family of *fundamental process building blocks* that will enable rapid prototyping and low-cost manufacturing of microsystems by a new paradigm.

End Goal: Enable broader exploitation of N/MEMS devices in defense systems by overcoming current cost and turnaround time challenges associated with meeting low-volume DoD needs

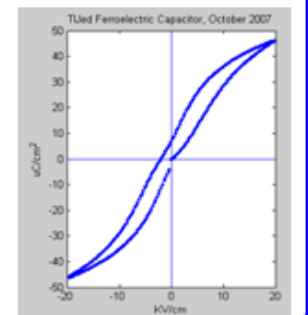
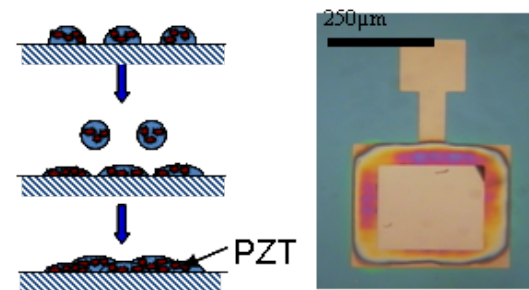
Printed MEMS



Printed Solar Cell



Printed Piezoelectrics





N/MEMS S&T Fundamentals University of California, San Diego



Center for RF MEMS Reliability
and Design Fundamentals

PI: G Rebeiz

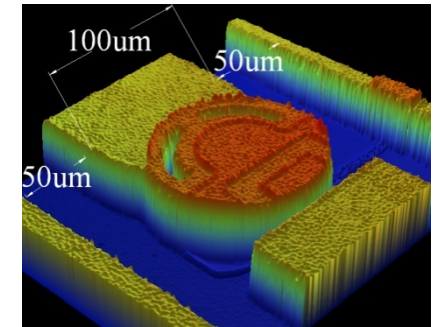
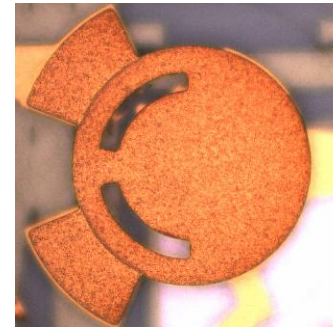
Mission: To develop fundamental understanding of microscale actuators, metal contacts, and dielectrics pertinent to high-power, high-reliability RF MEMS switches.

- RF MEMS actuators are sensitive to residual stress and stress gradients, resulting in low yields
- Angular design exhibits high tolerance to biaxial and stress gradients; exceptional flatness demonstrated, increasing yield
- Better insight into contact properties at high RF power for metal-contact switches
- Clear understanding of dielectric breakdown at high RF voltages for capacitive switches

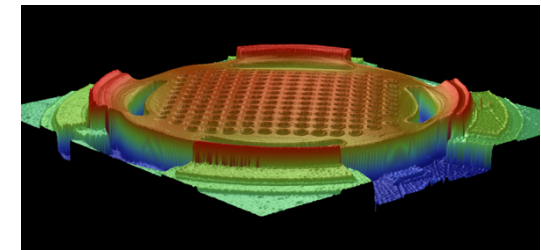
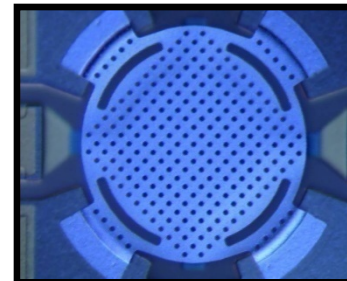
Key Accomplishments:

Demonstrated robust stress-tolerant RF MEMS actuator designs for enhanced reliability. Have transferred designs to industry (RFMD, Agilent, Raytheon); yield now > 94% on 6-inch wafers

End Goal: RF MEMS switches and circuits with high power handling capabilities (10-50W) at 0.1-30 GHz for radar and tunable radio.

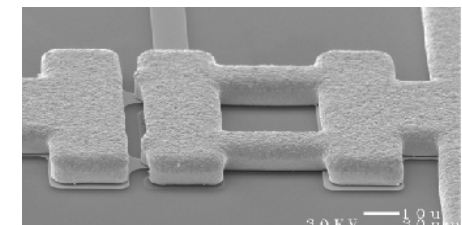


**Metal-contact stress tolerant actuator
(photograph and 3-D profilometer image)**



**Capacitive stress-tolerant actuator
(photograph and 3-D profilometer image)**

**Prior state-of-the-art
rectangular MEMS
actuator**





N/MEMS S&T Fundamentals California Institute of Technology



**Focus Center for NEMS-Based
SPM, Sensing, & Microfluidics**

PI: M Roukes

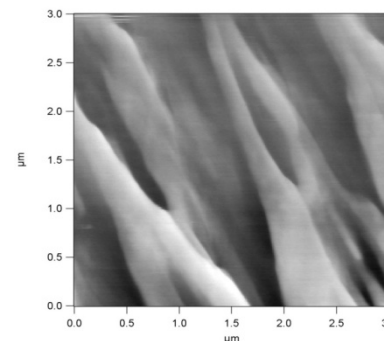
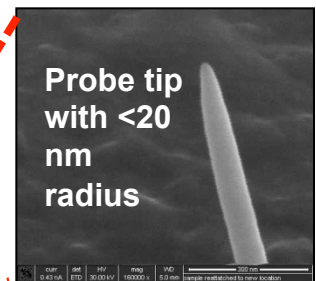
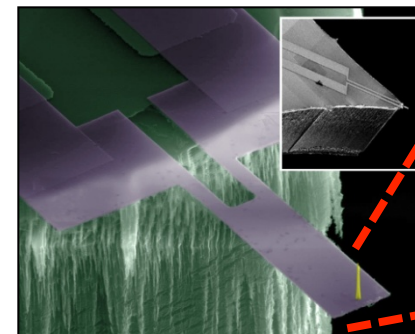
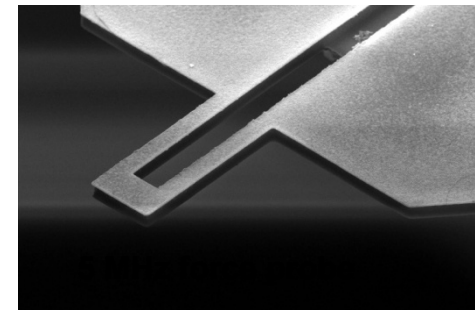
Mission: To develop high speed, high force sensitivity, self-sensing (no external optics needed), integrated probe tips at wafer-scale in a foundry-compatible fabrication process

- Probes can be directly integrated into existing SPM systems, allowing the U.S. to regain the advantage in cutting-edge SPM technology by enabling the investigation of heretofore unexplored force and time regimes at the nanoscale

Key Accomplishment:

Developed SPM probes based on NEMS technology that enable major advances in the state-of-the-art with respect to speed, sensitivity, fabrication, and spatial resolution for imaging at the nanoscale

End Goal: SPM probes enabling a better understanding of the specificity and kinetics of chem/bio sensing, which are key to improved sensors for CBW agent detection



**Image of calcite
generated by Caltech
high-speed probe in a
commercial AFM system**



N/MEMS S&T Fundamentals University of Illinois



**IMPACT Center for Advancement
of NEMS/MEMS VLSI**



PI: A Cangelaris

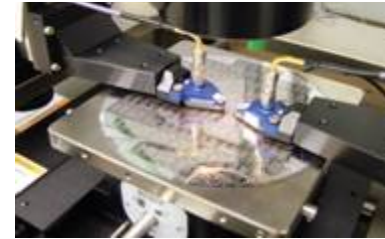
Mission: To enhance understanding of long-term survivability of MEMS through multi-scale modeling and experimentally-driven failure-rate quantification methods.

- First-principles characterization of surface and bulk dielectric charging in MEMS capacitive switches
 - Electronic monitoring of packaged MEMS devices
 - Scaling of device parameters and reliability
- Incorporated charging model into Coventor's ARCHITECT® software

Key Accomplishment:

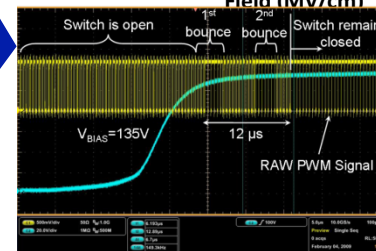
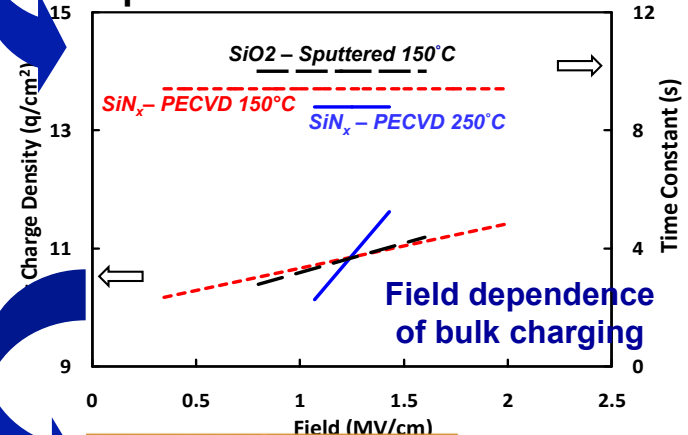
Developed validated computer models of the physical mechanisms governing MEMS performance and a stochastic MEMS CAD framework to enable fast, computer-aided, robust design of reliable MEMS devices

End Goal: New, advanced analytical tools and characterization techniques facilitating the design of reliable, high-performance, MEMS-based RF/microwave systems.



**RF MEMS
Switch**

Experimental characterization



**Electro-mechanical simulation
predicts behavior such as stiction
due to charging**

**Model switch
failure due
to stiction**



N/MEMS S&T Fundamentals Stanford University



Center on Interfacial Engineering
for MEMS (CIEMS)



PI: R Howe

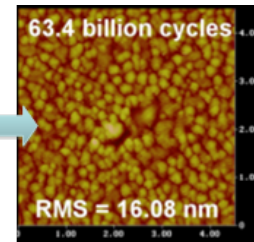
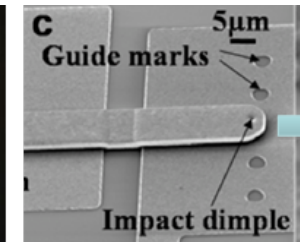
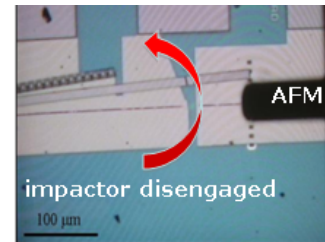
Mission: To develop high-performance photonic sensors and microsystems based on an advanced understanding of N/MEMS interfaces and interfacial engineering

- In situ micro-metrology of interfacial properties
- Fabrication of high-optical-quality microshells for visible/IR applications
- Fundamentals of waveguides and optical detectors using photonic crystals
- Flexible 3-D self-assembly for microsystems

Key Accomplishment:

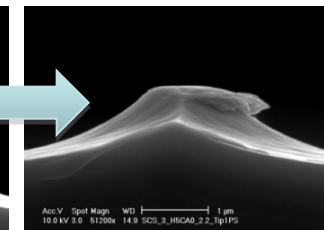
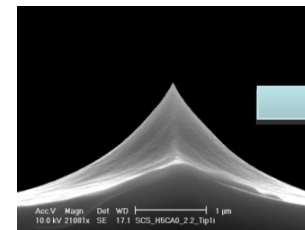
Developed materials, processes, and test structures for characterizing and enhancing N/MEMS interfaces, leading to major advances in photonic-crystal based optical sensing and communication building blocks

End Goal: Micro-encapsulated high-performance infrared sensors and optical signal-processing elements providing more reliable device functionality in N/MEMS involving contacting surfaces or cyclic operation

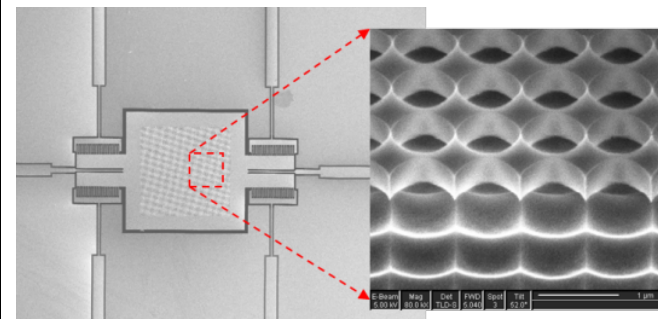


Impact wear testing

AFM image: onset of wear at impact site



Abrasion in uncoated Si probe tip



Monolithic silicon photonic crystal mirror MEMS scanner



N/MEMS S&T Fundamentals Harvard University



Harvard Center for Reconfigurable Photonic MEMS

PI: K Crozier

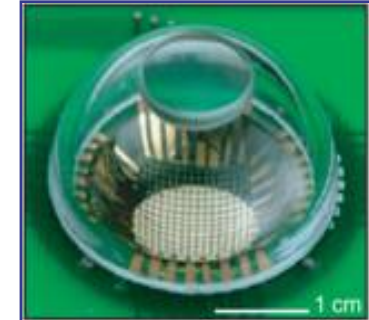
Mission: To develop a radical new class of photonic devices whose operations can be dynamically reconfigured in response to changing conditions

- Materials science: Mechanical behavior of high modulus materials on soft substrates
- Optical science: Plasmonic methods for controlling optical near- and far-fields
- Near-field optical forces: Physics of forces exerted by reconfigurable plasmonic devices

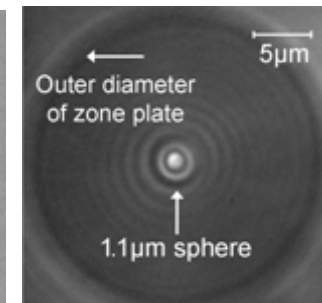
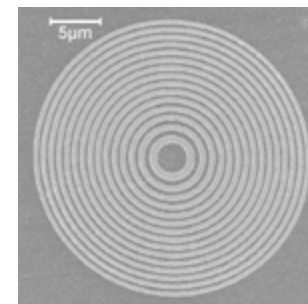
Key Accomplishment:

Demonstrated enhanced capabilities for the detection, identification, and manipulation biological materials, chemicals, and nanoparticles using surface plasmon phenomena

End Goal: Superior photonic devices for military imaging applications achieved by forming optoelectronics and plasmonics on soft elastomers incorporating actuators



Conceptual electronic eye with focal plane featuring adjustable curvature



Demonstration of microfluidic optical tweezer on-a-chip, with performance (trapping stiffness) comparable to conventional optical tweezers, but with a smaller footprint (<100 μm diameter)



N/MEMS S&T Fundamentals University of California, Berkeley



Center for Micro/Nano
Scaling-Induced Physics



PI: A Pisano

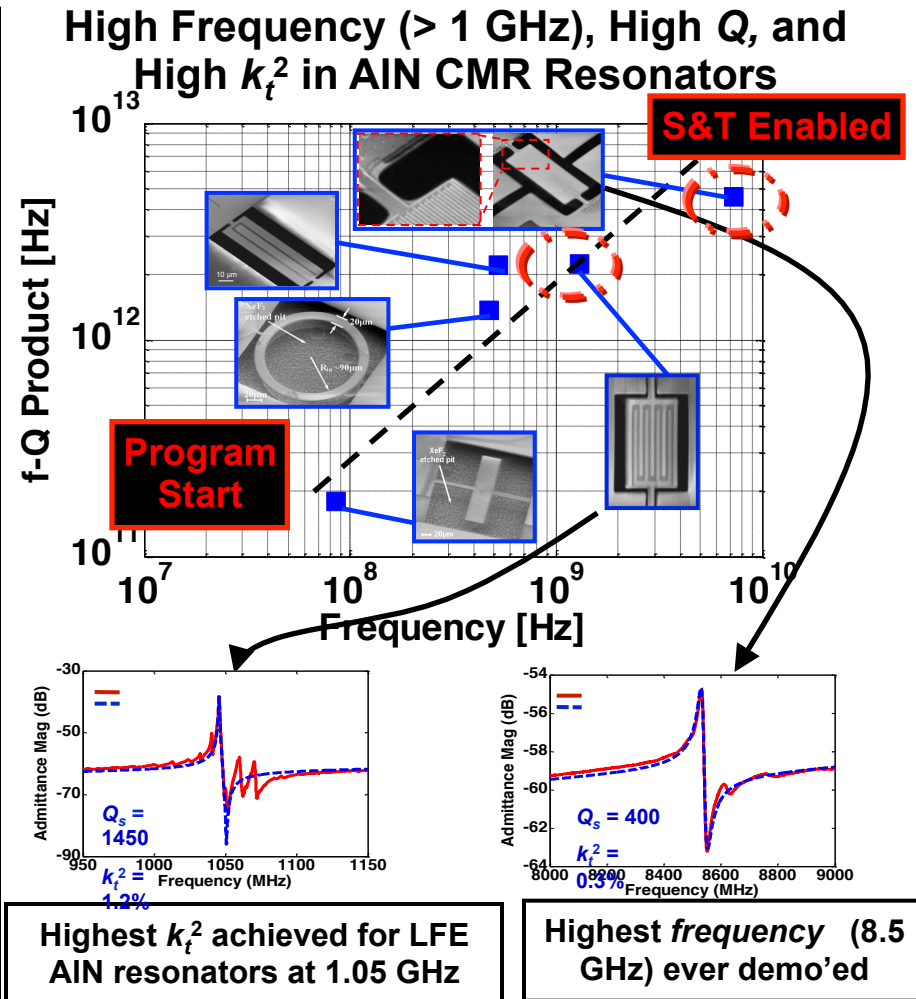
Mission: To understand, control, and engineer scaling-induced physics in N/ MEMS RF devices to facilitate their effective exploitation for DoD applications

- Physical phenomena that constrain the performance of N/MEMS devices as they are scaled and arrayed to increase performance
- Effects of harsh environments on performance of N/ MEMS devices (T, shock/vibration, chem)

Key Accomplishment:

Developed capabilities for controlling and manipulating micro/nano interfaces and demonstrations of major advances in noise, drift, damping and impedance matching

End Goal: Established limits to performance, stability, and robustness of N/MEMS RF devices under various environments and proven methods for extending them





N/MEMS S&T Fundamentals Carnegie Mellon University



Carnegie Mellon

**Center for Memory Intensive
Self-Configuring Integrated Circuits**

PI: T Schlesinger



Mission: To develop fundamental understanding of N/MEMS devices, circuits, and materials to enable and implement self-configuring integrated circuits

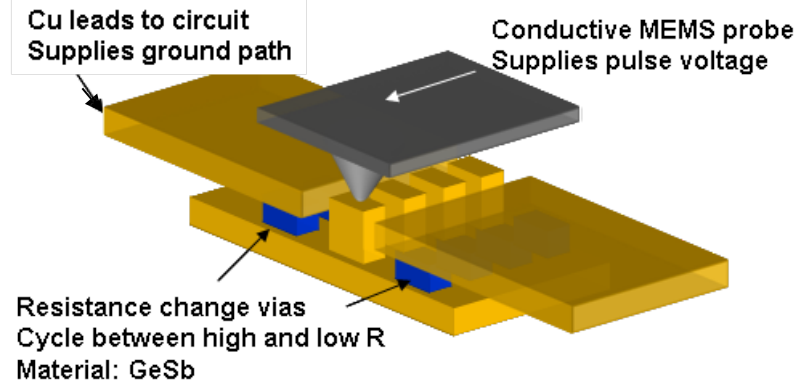
- Reliability and performance of probe sensors, actuators, and contacts; phase-change materials
- Heterogeneous integration of N/MEMS probes, nanoscale vias, and CMOS
- Switches exhibit 100X less capacitance than comparable transistors with equivalent performance
- Non-volatile/low-power devices

Key Accomplishment:

Developed advanced N/MEMS technologies involving resistance change materials, conductive probe arrays, and 3-D heterogeneous fabrication that will enable new types of reconfigurable electronic systems

End Goal: Demonstration of integrated N/MEMS devices and phase-change material switches enabling circuit reconfiguration for modified functionality of RF circuits

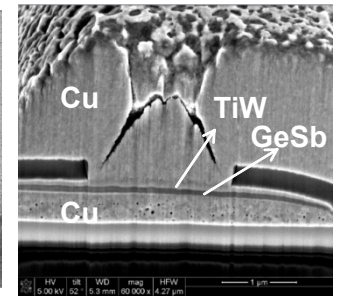
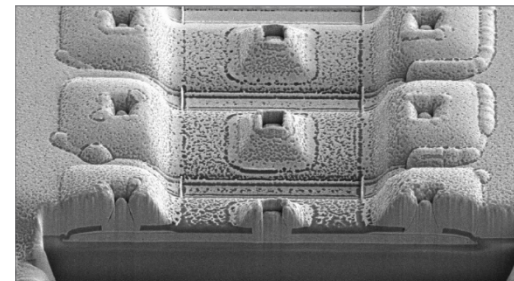
Switch Topology



Device Performance

Probe terminal

**Cross section
of one via**



Demonstrated: R-on: 0.1k Ω

R-off: 8 k Ω

Extensible to: R-on: 0.2 Ω

R-off: 200 Ω



N/MEMS S&T Fundamentals University of Colorado, Boulder



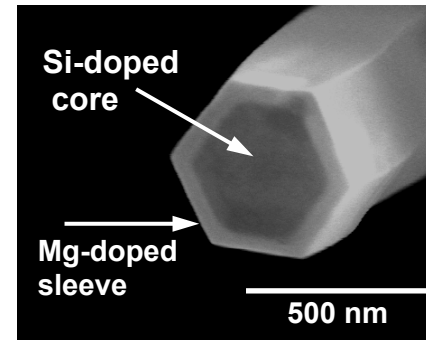
Nanoscale S&T for Integrated Micro/Nano- Electromechanical Transducers (iMINT)

PI: YC Lee

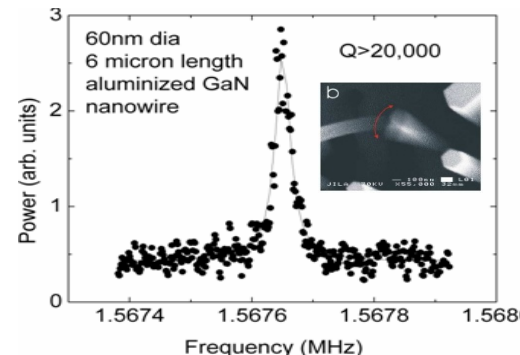
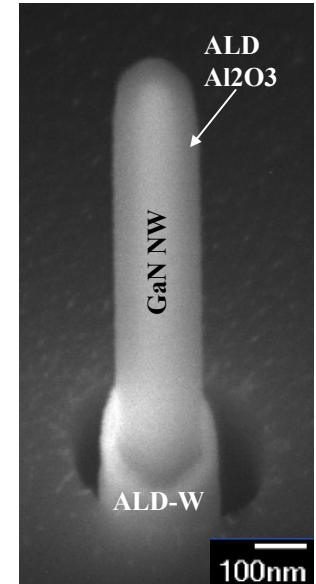
First *p-n* core-sleeve hetero-structure of a c-axis GaN nanowire

Mission: To develop S&T for repeatable, predictable, and reliable integrated N/MEMS enabled by nanostructures; to develop nanoscale building blocks for N/MEMS

- Demonstrated first *p-n* core-sleeve hetero-structure of a c-axis GaN nanowire; will lead to devices that are more efficient and reliable than a-axis GaN nanowire-based devices with intrinsic defects
- Defect-free GaN NWs enable 10X increase in Q for GaN nanowire-based resonators
- Will enable, low-power high-performance photonic and RF devices for displays, sensors, and lasers for NLOS communication



ALD-based W and Al₂O₃ multilayer deposited on GaN NWs for improved electrical, optical, thermal, and mechanical inter-connects



Measured Q of defect-free GaN (c-axis) nanowire-based resonators; Q ~ 2800 for a-axis GaN NWs containing defects

Key Accomplishment:

Developed novel experimental techniques for characterizing mechanical, optical, and RF properties of nanowire-, nanotube-, and graphene-based N/MEMS

End Goal: Demonstration of a NEMS device (GaN resonator or graphene nano-switch) powered by an embedded battery in a package enabled by an ALD/MLD barrier coating: an iMINT microsystem



N/MEMS S&T Fundamentals University of California, Irvine



Micro/Nano Fluidics
Fundamentals Focus (MF3) Center

PI: A Lee

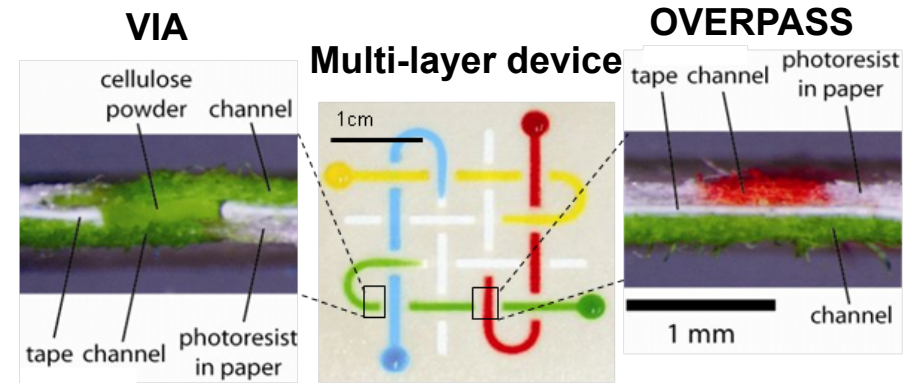
Mission: To develop an advanced understanding of critical fundamental issues in microfluidics important to manufacturing and integration processes

- At platform level: detection limits, material and process integration, surface science, micro-scale fluid dynamics, sort and separate constituents, reliability, and efficient transport mechanisms
- At manufacturing/integration level: material selection and material interface/surface science
- Provide small, light-weight, low-power, easy-to-use, field-deployable soldier health and environmental diagnostic devices

Key Accomplishment:

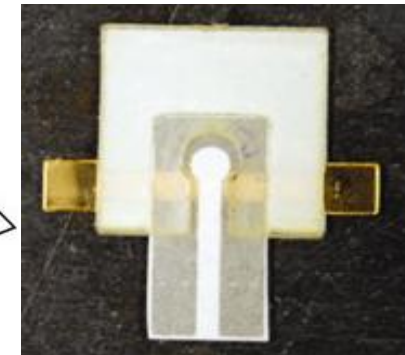
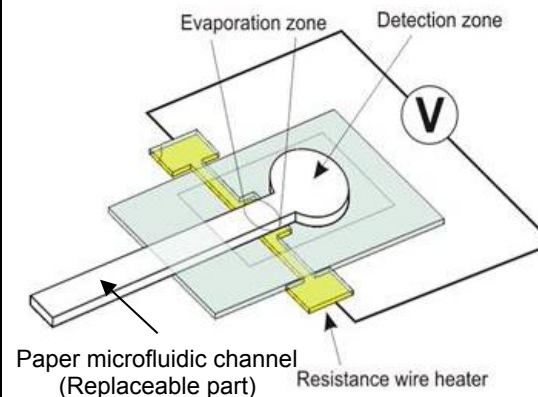
Developed and demonstrated chip-scale integrated fluid processors for the rapid and high-sensitivity analysis of molecular content important to soldier health and environmental monitoring

End Goal: Useful suite of microfluidics modules, established foundry process for micro/nano fluidics, and integration of multiple modules



Complex microfluidic manifold in paper

Addition of metal traces to paper microfluidics:



Microfluidic concentrator: Analytes are concentrated in an "evaporation zone"



N/MEMS S&T Fundamentals Cornell University



Cornell University – *HARMs* Harnessing Active Resonant MEMS

PI: J Parpia

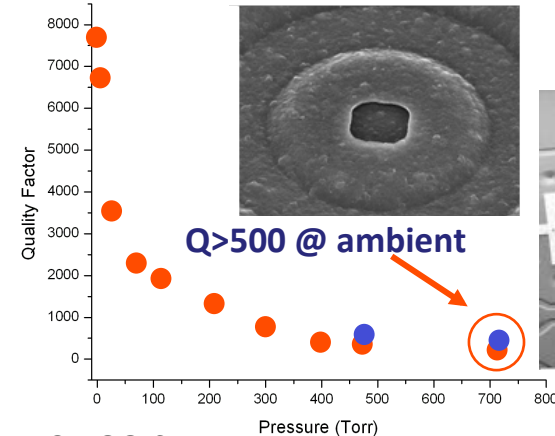
Mission: To develop superior high-Q MEMS resonators fabricated in CMOS technology and able to operate in fluid environments

- Resonators operating in ambient environments (air/liquids); $Q \sim 500$ in air
- Resonators ready for integration with readout electronics
- CMOS integration overcomes constraints imposed by lab-specific N/EMMS fabrication requirements and associated integration challenges

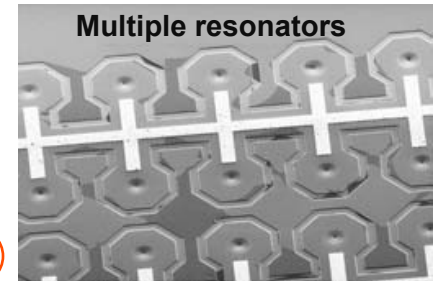
Key Accomplishment:

Demonstrated advanced physical and chemical sensing capabilities using selected MEMS and NEMS devices suitable for integration with CMOS electronics

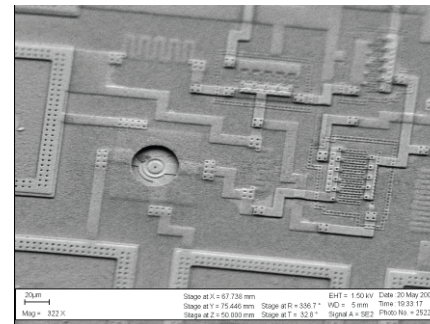
End Goal: Fully integrated low-cost, high performance RF MEMS devices; low-mass, low-power sensors for UAVs and miniature UGS



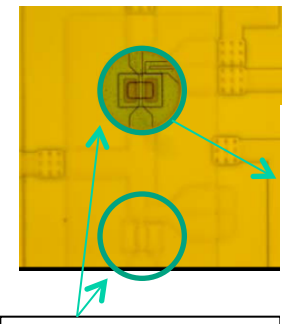
CMOS-fabricated dome resonator and measured Q vs. Pressure



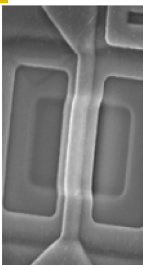
Next-gen CMOS-MEMS



Dome resonator, resistive drive, capacitive detector



Dual resonators for differential measurements

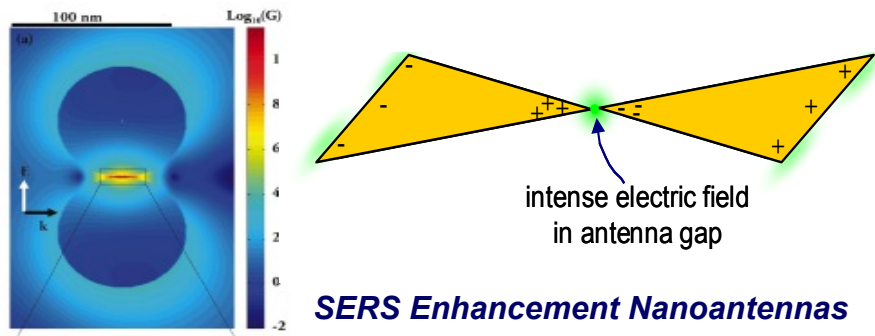




N/MEMS S&T Fundamentals Successful Transitions

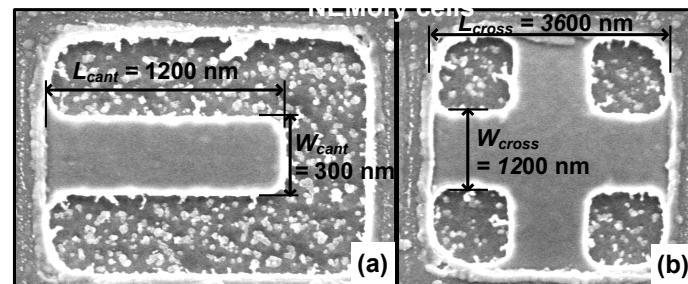
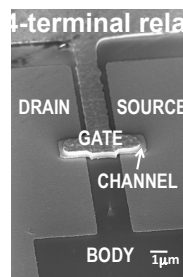


SERS S&T Fundamentals (PM: Polla) Harvard University



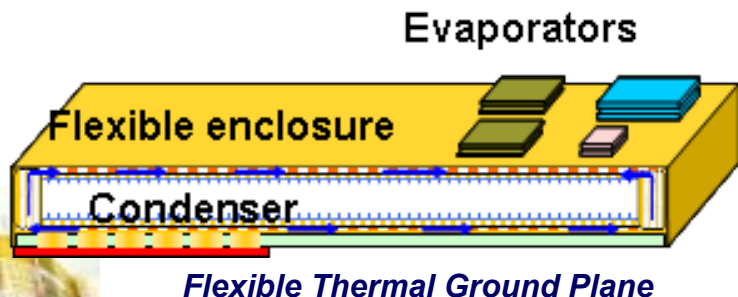
SERS nanoparticles integrated in a nanoantenna structure lead to extraordinary SERS enhancement (BAA 07-61)

NEMS (PM: Akinwande) UC Berkeley / Stanford University



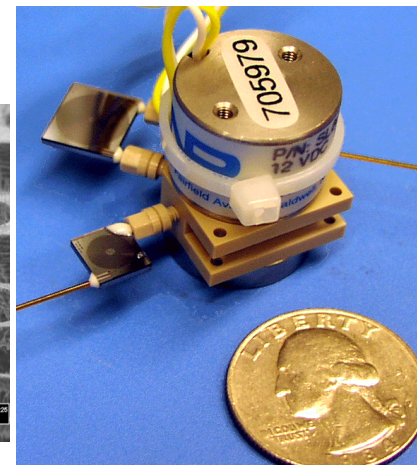
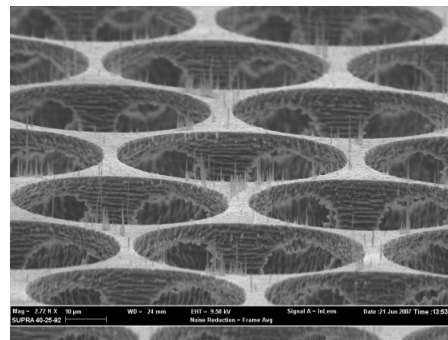
Study of micro-interconnect and interfaces between materials has led to NEMS (BAA 07-18)
Nanomechanical Switches for Digital ICs

Thermal Ground Plane (PM: Kenny) University of Colorado



i MINT S&T enabled development of novel ALD Flexible Thermal Ground Plane (FTGP) concept (BAA 07-36)

Micro Gas Analyzer (DTRA)



Promising technology is being transitioned to DTRA



N/MEMS S&T Fundamentals Performers

N/MEMS S&T II 2010-2012

- **Carnegie Mellon University**
- **Harvard University**
- **Stanford University**
- **UC Berkeley**
- **UC Irvine**
- **UC San Diego**
- **University of Colorado**



Key DARPA MTO Themes

- 1. N/MEMS Enables Significant New Levels of Performance**
- 2. Scaling – “Smaller is Better”**
- 3. N/MEMS Integration**
- 4. Enabling Completely New Opportunities**
- 5. Basic Research Infrastructure is Important**



DARPA N/MEMS Summary

What are the opportunities for MEMS and nanotechnology?

1. **Greatest opportunities for MEMS and nanotechnology (N/MEMS) are to enable new systems**
2. **Clear motivation for continuing development of N/MEMS technology is to enhance performance, not to drive down cost**
3. **Recognized needs (applications) are the most important drivers for nanotechnology development, not undirected fundamental research**
4. **Multi-domain scaling is the key to performance-driven nanotechnology (there remains *plenty of room at the bottom*)**
5. **DARPA investments in developing a N/MEMS basic science research infrastructure have produced a highly interactive community of academic, industrial, and government researchers**



Thank you

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